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For

**METHOD AND APPARATUS FOR SWITCHING AMPLIFICATION
HAVING VARIABLE SAMPLE POINT AND VARIABLE ORDER
CORRECTION**

by

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BACKGROUND OF THE INVENTION

1. Field of the Invention

The invention relates generally to switching amplifiers, and more specifically, to error correction in switching amplifiers.

5 2. Background of the Invention

Digital audio switching power amplifiers are well known and widely used, for example, in the automotive audio industry. In such amplifiers, a digital audio signal which has been pulse width modulated is applied to a switching power amplifier which drives a load, typically a speaker, to reproduce an audio signal represented by
10 the pulse width modulated signal.

The audio fidelity of such high efficiency switching amplifiers is typically determined by the non-idealities of the switching power stage. Additionally, digital audio switching power amplifiers that do not incorporate feedback suffer from poor power supply rejection. Prior attempts to improve fidelity and power supply rejection
15 in light of these non-idealities have proposed incorporating a feedback mechanism to digitally correct the distortion introduced by these non-idealities. However, the existing digital correction limits the input signal dynamic range, thus reducing the maximum power produced by the switching amplifier. In addition, with such existing digital correction, if the power stage delay becomes too large, then the feedback
20 system may become difficult to stabilize.

BRIEF DESCRIPTION OF THE DRAWINGS

The drawings accompanying and forming part of this specification are included to depict certain aspects of the invention. A clearer conception of the invention, and of the components and operation of systems provided with the invention, will become more readily apparent by referring to the exemplary, and therefore nonlimiting, embodiments illustrated in the drawings. In the drawings, like reference numerals (if they occur in more than one view) designate the same or similar elements. The invention may be better understood by reference to one or more of these drawings in combination with the description presented herein. It should be noted that the features illustrated in the drawings are not necessarily drawn to scale.

FIG. 1 is a block diagram of a switching power amplifier incorporating an exemplary embodiment of the present invention;

FIG. 2 is a more detailed block diagram of a switching power amplifier, in accordance with an exemplary embodiment of the present invention;

FIG. 3 is a block diagram of an integrating error amplifier usable in **FIG. 2**;

FIGS. 4-6 are timing diagrams illustrating different modes of operation for digital correction, in accordance with an aspect of the present invention;

FIG. 7 is a graph of the transitions between the different correction modes, illustrated in **FIGS. 4-6**;

FIGS. 8 and 9 are additional timing diagrams showing correction mode transitions, in accordance with an aspect of the present invention;

FIG. 10 is a block diagram of an error amplifier saturation detector, in accordance with an aspect of the present invention; and.

FIGS. 11 and 12 are state diagrams of the error amplifier order adjustment, in accordance with aspects of the present invention.

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DETAILED DESCRIPTION

The invention and the various features and advantageous details thereof are explained more fully with reference to the nonlimiting embodiments that are illustrated in the accompanying drawings and detailed in the following description. It
10 should be understood that the detailed description and the specific examples, while indicating specific embodiments of the invention, are given by way of illustration only and not by way of limitation. Various substitutions, modifications, additions and/or rearrangements within the spirit and/or scope of the underlying inventive concept will become apparent to those of ordinary skill in the art from this disclosure.

15 The invention may include a method and/or apparatus for a dual output voltage regulator.

In accordance with one aspect of the invention, a switching power amplifier is presented, including, a power stage having an input and an output, the output providing an amplified pulse modulated output signal, and a digital correction circuit
20 having a first input for receiving a pulse modulated input signal, a second input coupled to the output of the power stage, and an output coupled to the input of the power stage, the digital correction circuit providing a corrected pulse modulated signal to the input of the power stage that has been corrected as a function of a duty

ratio of said pulse modulated input signal.

In accordance with another aspect of the invention a multiple-order controllable error amplifier is used in the digital correction circuit, the error amplifier having a first input for receiving a digital pulse width modulated reference input
5 signal, a second input coupled to the output of the power stage, and an output providing an error signal which is used to produce the pulse modulated signal that is input to the power stage. In addition, an order control unit is coupled to receive the error signal and operates to sense a saturation state of the error amplifier, and to adjust an order of the error amplifier as a function of the saturation state.

10 These and other aspects and features solve the above-noted deficiencies in the prior art, and provide higher performance and the use of less expensive power stage components. In addition, adjustment of the order of the integrating error amplifier permits operation of the power stage with an output swing up to the power supply rails, thus increasing a power output of the power stage.

15 Referring now to **FIG. 1**, a block diagram of a switching power amplifier with variable sample point and variable order correction is disclosed. The switching amplifier 10 functions to amplify signal source 12 which is conditioned by signal processing unit 13 and variable sample point variable order digital correction block 14. It will be understood that, although the particular illustrated embodiment is an
20 audio amplifier, and thus signal source 12 is an audio signal source, the present invention is also applicable to other forms of signal amplification including, for example, a motor control signal, or the like. It should also be noted that when signal source 12 is an audio signal source, it may be any type of signal source that may be used to produce an audio signal including, for example, an audio recording from a

record, compact disc (CD) or magnetic disc, a received radio signal, a received television audio signal, an internet audio signal, or any other type of audio signal.

The output of source **12** is applied to signal processing unit **13** which produces a digital pulse width modulated signal representation of signal source **12**, in a known manner. In the disclosed exemplary embodiment, the output of signal processing unit **13** takes the form of two digital signals X1 and X2, with signal X2 being an inverted and delayed signal derived in a known manner from signal X1. The output of signal processing unit **13** is applied to variable sample point variable order digital correction unit **14** which provides a corrected pulse width modulated signals Y1, Y2 for application to the power stage **15** of switching power amplifier **10**. Outputs Y1 and Y2 of correction unit **14** are corrected versions of output signals X1 and X2 produced by signal processing unit **13**.

Power stage **15** of switching amplifier **10** is illustrated in **FIG. 1** as a full bridge amplifier having a particular configuration, however, other types of full bridge amplifiers are acceptable. In addition, while the disclosed embodiment for power stage **15** is a full bridge amplifier, it will be understood that a half bridge amplifier embodiment are also acceptable.

When power stage **15** is a full bridge amplifier, it will typically be constructed using two half bridge amplifiers. In that case, signal Y1 is coupled to drive one of the half bridges, and signal Y2 is coupled to drive the other half bridge. In the disclosed embodiment, transistors **16** and **18** form one half of the full bridge, and transistors **28** and **30** form the other half of the full bridge. Amplifier output signals Z1 and Z2 are sensed and are coupled to correction unit **14** to provide feedback.

In the disclosed exemplary full bridge embodiment, output Y1 of correction unit 14 is connected to a P-channel transistor 16 and an N-channel transistor 18 which together form a first half bridge of power stage 15. In the illustrated form, P-channel transistor 16 has a source connected to a positive power supply terminal labeled V_{DD} .

5 A gate of transistor 16 is connected to both a gate of N-channel transistor 18 and to the output of unit 14. A drain of transistor 16 is connected to a drain of N-channel transistor 18. A source of N-channel transistor 18 is connected to a ground or a voltage reference terminal. The drains of transistors 16 and 18 are connected to a first terminal of an inductor 20. A second terminal of inductor 20 is connected to a first terminal of a load, for example, speaker 22, and to a first terminal of capacitor 24. A second terminal of speaker 22 is connected to a second terminal of capacitor 24.

The Y2 output of correction unit 14 is connected to a P-channel transistor 28 and an N-channel transistor 30 which together form a second half bridge of power stage 15. The Y2 output is connected to a gate of each of transistors 28 and 30.

15 Transistor 28 has a source electrode connected to the power supply terminal, V_{DD} . A drain of transistor 28 is connected to a drain of transistor 30 and to a first terminal of inductor 32. A source of transistor 30 is connected to the ground reference terminal. A second terminal of inductor 32 is connected to the second terminal of speaker 22 and to the second electrode of capacitor 24.

20 Signal Z1 is sensed as a first output of power stage 15 at the junction of transistors 16 and 18 and inductor 20. Signal Z2 is sensed as a second output of power stage 15 at the junction of transistors 28 and 30 and inductor 32.

It should be appreciated that various elements of switching amplifier 10 may be incorporated into a single integrated circuit depending upon design choice. For

example, the full bridge amplifier formed by transistors **16, 18, 28, and 30** of power stage **15** may be incorporated into an integrated circuit along with units **13** and **14**, depending upon the power requirements of a particular application. For particularly high wattage outputs, it may be desirable to implement transistors **16, 18, 28, and 30** as discrete power devices.

It will also be understood that power stage **15** formed by transistors **16, 18, 28, and 30** may be implemented by other circuitry and other circuit techniques than the devices illustrated. The type of switching amplifier chosen depends on the voltage ranges to be used and the particular product application. In operation, signal source **12** provides a signal to signal processing unit **13** which produces modulated reference signals **X1** and **X2**.

Signal processing unit **13** functions to take the signal produced by signal source **12** and to perform a modulation conversion to convert the signal produced by source **12** into a digital pulse modulated signal. In the event that the audio signal is already in pulse modulated form, then signal processing unit **13** may possibly be eliminated and no modulation conversion technique may be required.

Variable sample point variable order digital correction unit **14** may modify a sampling point, as described in more detail below with reference to FIGS. 4-6, in order to produce corrected signals **Y1** and **Y2** from reference signals **X1** and **X2**.

Signal processing unit **13** provides a pulse width modulated (PWM) signal at a predetermined clock rate having a corresponding switching period, T_s , that functions as a switching signal. The PWM switching signal is conditioned by correction unit **14** and applied to transistors **16, 18, 28** and **30**.

Therefore, each pulse of signal Y2 has substantially the same pulse width as a corresponding pulse of the signal Y1, but inverted and delayed in time. The outputs of transistors 16, 18, 28, and 30 are applied to a low pass filter formed by inductors 20 and 32 and capacitor 24 which together form a conventional passive LC network.

5 Turning now to **FIG. 2**, disclosed is a further detail of one implementation of the switching power amplifier including digital correction circuit 14 of **FIG. 1**. Digital pulse modulated input, in the form of reference signals X1, X2, is connected to an input digital pulse conditioner 201, mode control logic 202, and as a first input to digital pulse edge corrector 203. In one form, the digital pulse modulated input
 10 signal X1, X2 is a digital PWM input signal, possibly including a differential mode PWM signal, however, other types of digital pulse modulated signals may also be used. An output of the digital pulse conditioner 201 is a clean PWM reference, and is applied as a first input to integrating error amplifier 204. The output of integrating error amplifier 204 is an analog correction signal, and is applied to an input of analog-
 15 to-digital converter (ADC) 206. The output of ADC 206 is a digital correction signal, and is provided as a second input to digital pulse edge corrector 203. A first clock signal is connected to a clock input of ADC 206 and to a first clock input to digital pulse edge corrector 203 for providing a clock having a frequency four times the switching frequency, F_{sw} ($1/T_s$). In one embodiment, the switching frequency, F_{sw} , is
 20 375 kHz, which results in ADC 206 having a sampling frequency of 1500 kHz. A second clock signal is connected to a second clock input of digital pulse edge corrector 203, for providing a clock signal labeled F_c . In one form, the frequency F_c is 48 MHz. Clock signal F_c is a high speed PWM quantization clock used to define the placement of the PWM edges of the digital pulse width modulated input signal X1

and X2. Similarly, clock signal Fc is used to define the placement of the PWM edges of the corrected digital pulse width modulated signals Y1 and Y2.

The output Y1, Y2 of digital pulse edge corrector **203** is connected to power stage **15** and provides a corrected digital pulse modulated signal as described with reference to **FIG. 1**. The output Z1, Z2 of power stage **15** provides an amplified pulse modulated output signal and is connected to a second input of integrating error amplifier **204**. An output of mode control logic circuit **202** is applied as a fifth input to digital pulse edge corrector **203**.

An output of order control logic **207** is applied to control an order of integrating error amplifier **204**. In the disclosed exemplary embodiment, order control logic circuit **207** has two possible inputs, depending on a particular embodiment. In one embodiment, an input of order control logic **207** is provided from the output of ADC **206**, and in another embodiment, an input to order control logic circuit **207** is provided from integrating error amplifier **204**. The use of these two different inputs will be described in detail with reference to the state diagrams of **FIGS. 11 and 12**.

In operation, a digital correction signal provided by ADC **206** is applied to digital pulse edge corrector **203**, which adjusts a timing of a rising edge, falling edge or both rising and falling edges of individual pulses in reference signals X1, X2 to produce corrected PWM signal Y1, Y2. In one embodiment, depending on the nature of the signal error represented by the digital correction signal provided by ADC **206**, digital pulse edge corrector **203** will function to advance some digital pulse edges in time while other digital pulse edges will be delayed in time. In this manner, digital pulse edge corrector **203** functions to compensate for power supply noise and error

and nonlinearity in power stage **15** by adjusting a timing of when one or both edges of each digital pulse occur, thus forming a discrete-time pulse edge correction. Depending upon a duty ratio of the digital pulse modulated input signal X1, X2, as determined by mode control logic circuit **202**, the samples of the digital correction
5 signal produced by ADC **206** are selected such that the time available for the delay through the power stage **15** and the analog-to-digital converter **206** is maximized. The ability to accommodate a larger delay allows the use of lower cost components for the power stage **15** as well as the use of existing off-the-shelf integrated power stages. In one particular embodiment, there are three different correction modes
10 depending on whether the digital pulse modulated input signal has a low duty ratio, a medium duty ratio (close to 50%), or a high duty ratio. These three correction modes are presented below in more detail with reference to FIGS. 4-6.

Further, integrating error amplifier **204** is typically a multiple order integration amplifier. In one embodiment, integrating error amplifier **204** is a third order
15 amplifier. The order control logic circuit **207** allows the order of the integration error amplifier **204** to be adjusted depending upon the saturation state of integrating error amplifier **204**. In particular, and in accordance with one exemplary embodiment of the invention, the order of integrating error amplifier **204** may be lowered all the way down to first order. In addition, order control logic **207** allows the output of
20 integrating error amplifier **204** to be set to zero for the purpose of a reset condition. In the event of a saturation event, as determined by order control logic **207**, order control logic **207** reduces an order of integrating amplifier **204**. Saturation may be detected in any number of ways, including, for example, by sensing the output of analog-to-digital converter **206**, or by sensing the outputs of each of the individual integrating

amplifiers within integrating error amplifier **204**. When saturation is not detected by order control logic circuit **207**, the order of integrating error amplifier **204** may be increased up to the maximum allowable order. This permits accommodation of large signal transients which allows the use of less margin in the duty ratios (which are
 5 fundamentally limited between zero and one). This, in turn, results in higher maximum power ratings for power stage **15** by permitting the output of power stage **15** to reach a level substantially equal to the power supply voltage, V_{DD} .

Referring now to **FIG. 3**, shown is a simplified block diagram of an example of integrating error amplifier **204**. The clean PWM reference signal (provided by
 10 input digital pulse conditioner **201**) is applied to the noninverting input of summer **301**, and the PWM output (provided by power stage **15**) is applied to the inverting input of summer **301**. The output of summer **301** is applied to a series of integrating amplifiers **302**, **303**, and **304**, and the respective outputs K_1I_1 , K_2I_2 , and K_3I_3 are applied to summer **305** which produces the analog correction signal, $K_1I_1+K_2I_2+K_3I_3$.
 15 It should be noted that the disclosed embodiment of integrating error amplifier **204** is simply one of several different types of structures that are acceptable. In addition, although a third order integrating error amplifier is disclosed, it will be appreciated that any multiple order amplifier would be acceptable. Further, the individual integrators and summers within integrating error amplifier **204** may be formed by
 20 various types of circuits, including, for example, differential amplifiers and/or operational amplifiers and accompanying circuitry, as is known in the art.

Referring now to **FIGS. 4-7**, presented are timing diagrams illustrating the operation of digital pulse edge corrector **203** under control of mode control logic **202**. Each diagram shows positive and negative reference signals, X_1 , X_2 , positive and

negative corrected output signals, Y1, Y2, and a reference ramp signal 401 used to illustrate timing. Also shown in each diagram is the timing of the samples used from ADC 206 to perform the correction. As may be seen with reference to FIGS. 4-7, the timing of the samples changes depending upon the correction mode as determined by mode control logic 202. The switching period, T_s , is represented by the time between the peaks of the reference ramp at times $(2n-1)T_s/2$ and $(2n+1)T_s/2$. As mentioned above, the sampling frequency of the ADC 206 is four times the switching frequency, F_{sw} , meaning that the sampling period is one quarter of the switching period, T_s . Thus, ADC 206 samples the analog correction signal produced by integrating error amplifier 204 at the beginning of the switching period at time $(2n-1)T_s/2$, and then at times $(2n-1/2)T_s/2$, $(2n)T_s/2$, $(2n+1/2)T_s/2$ and finally at the end of the switching period (the beginning of the next switching period) at time $(2n+1)T_s/2$. In accordance with the disclosed embodiment, different samples produced by ADC 206 are used by digital pulse edge corrector 203, as a function of the duty ratio of the digital PWM reference signal, X1, X2 as determined by mode control logic 202.

Specifically, according to the exemplary disclosed embodiment, as shown in FIG. 4, if mode control logic 202 determines that a low duty ratio exists (Mode A), then the sample taken at time $(2n-1/2)T_s/2$ is used to correct both the falling and rising edges of the pulse width of the negative reference, X2, to produce corrected negative pulse, Y2, and the sample taken at time $(2n+1/2)T_s/2$ is used to correct both the rising and falling edges of the pulse width of the positive reference, X1, to produce corrected positive pulse, Y1. Referring to FIG. 5, if mode control logic 202 determines that a medium duty ratio exists (Mode B), then the sample taken at time $(2n-1)T_s/2$ is used to correct the falling edges of the pulse width of both the positive

and negative references, X1, X2, and the sample taken at time $(2n)T_s/2$ is used to correct the rising edges of the pulse width of both the positive and negative references, X1, X2, to produce corrected positive and negative output pulses, Y1, Y2. Finally, referring to **FIG. 6**, if mode control logic **202** determines that a high duty ratio exists (Mode C), then the sample taken at time $(2n-1/2)T_s/2$ is used to correct both the falling and rising edges of the pulse width of the positive reference, X1, to produce corrected positive output pulse, Y1, and the sample taken at time $(2n+1/2)T_s/2$ is used to correct both the rising and falling edges of the pulse width of the negative reference, X2, to produce corrected negative output pulse, Y2.

10 In this manner, samples taken by ADC **206** near a switch transition that are likely to be noisy are not used for pulse correction, and only samples taken when there is no switch transition are used.

Turning now to **FIG. 7**, presented is a graph of an optional function of mode control logic **202** when determining correction mode from duty ratio. A benefit of this optional embodiment of mode control logic **202** is to maintain correction mode A for low duty ratios, correction mode B for medium duty ratios and correction mode C for high duty ratios, while at the same time minimizing unnecessary transitions between the correction modes. To accomplish this, hysteresis bands **701** and **702** are inserted at the transitions to reduce the number of mode changes. Hysteresis band **701** is inserted in the transition between mode A and mode B, and hysteresis band **702** is inserted in the transition between mode B and mode C.

Another optional function of mode control logic **202** is to control digital pulse edge corrector **203** to provide smooth transitions between correction modes is shown in **FIGS. 8** and **9**. To smooth the transitions, additional samples are used during the

transitions in order to ensure that no edges are left uncorrected. In **FIG. 8**, a transition between correction mode A and mode B is shown, and in order to ensure a smooth transition, the sample taken at time $(2n-1/2)T_s/2$ is used to correct only the falling edge of the negative reference signal, X2, to generate the falling edge of negative corrected signal, Y2, and the very next sample taken at time $(2n)T_s/2$ is used to correct the rising edge of the same signal, X2, to generate the rising edge of negative corrected signal, Y2. In **FIG 9**, when transitioning from mode B to mode C, the sample taken at time $(2n)T_s/2$ is used to correct the rising edge of positive reference signal, X1, to generate the rising edge of positive corrected output signal, Y1, and the very next sample taken at time $(2n+1/2)T_s/2$ is used to correct both the rising and falling edges of negative reference signal, X2, to generate corrected output signal, Y2.

Turning now to **FIGS. 10 and 11**, presented is an exemplary embodiment of the operation of order control logic 207 (**FIG. 2**). **FIG. 10** is a block diagram of an exemplary integrator saturation detector. In practice, the circuit of **FIG. 10** may be repeated for each integrator so that the saturation state of each integrator may be sensed. For example, in the integrating error amplifier of **FIG. 3**, three integrator saturation detectors may be used, one connected to the output of each integrator 302, 303 and 304. Referring to **FIG. 10**, the output of the integrator being sensed is connected to the positive input of comparator 1001 and also to the negative input of comparator 1002. The negative input of comparator 1001 and the positive input of comparator 1002 are connected to appropriate thresholds so that comparator 1001 senses a high saturation state and comparator 1002 senses a low saturation state. The outputs of comparators 1001 and 1002 are applied to OR gate 1003, and the output of OR gate 1003 is applied to the D input of a D-type flip-flop 1004. A clock signal is

also applied to flip-flop 1004. In operation, when the sensed integrator saturates in either a high state or a low state, for example, when the output of the integrator is substantially the same as the high or low supply voltage, then either the high or low saturation state comparators 1001, 1002 will transition, and will activate OR gate 5 1003. Flip-flop 1004 may be clocked using an appropriate clock signal to synchronize the saturation detector output with the rest of the system.

Turning now to FIG. 11, shown is a state diagram of the operation of order control logic 207. Beginning in state 1101, the integrating error amplifier is operating in its highest order, in this example, third order. If saturation of the third integrator is 10 detected then a transition is made to state 1102 where the order of the integrating error amplifier is reduced to 2. Second order operation will continue until either saturation of the first or the second integrators is sensed, on which case a transition is made to state 1103 (first order operation), or a predetermined time expires, in which case a transition is made back to state 1101, and third order operation is continued.

15 If while in state 1101, saturation of the first or second integrators is detected, a transition is made from third order operation, state 1101, to first order operation, state 1103. In state 1103, if after a predetermined time no saturation events are detected, a transition is made to state 1102, and second order operation is resumed. If a predetermined time expires while in state 1102 without any saturation events being 20 detected, a transition is made back to state 1101, and third order operation is resumed.

FIG. 12 presents a state diagram of an alternative embodiment of the operation of order control logic 207. In this embodiment, the saturation states of each individual integrator are not sensed, but rather, the output code of the ADC 206 is monitored to detect a saturation event. This may be done in a known manner,

including sensing that the digital code produced by ADC 206 remains substantially constant for a predetermined time, or reaches a predetermined magnitude corresponding to integrator saturation. Beginning in state 1201, the integrating error amplifier 204 is operating as a third order integrator. If saturation is detected, a transition is made to state 1202, where second order operation is performed. If saturation continues to be sensed, a transition is made to state 1203 where first order operation is performed. If the digital code produced by ADC 206 indicated no saturation for a predetermined time, a transition is made back to state 1202, and second order operation is resumed. If no saturation is detected for another predetermined time, a transition is made back to state 1202 where third order operation is performed.

The invention may include a method and/or apparatus for adjusting the sample time and order associated with a digital correction system for maximizing output power and minimizing power stage delay sensitivity of a full bridge switching power stage. Presented are several different exemplary embodiments for performing these operations. As one of ordinary skill in the art will recognize in light of this disclosure, the methods contained herein may be implemented via hardware (for example, via an application specific integrated circuit), or via software.

Certain embodiments of the invention allow the sample point to be changed as a function of the duty ratio of the PWM signal thus allowing higher performance and use of less expensive power stage components. In addition, adjustment of the order of the integrating error amplifier permits operation of the power stage with an output swing up to the power supply rails, thus increasing a power output of the power stage.

One of ordinary skill in the art will recognize in light of this disclosure that the invention includes applications ranging from audio amplifiers to motor control.

The terms a or an, as used herein, are defined as one or more than one. The term plurality or multiple, as used herein, is defined as two or more than two. The
5 terms including and/or having, as used herein, are defined as comprising (i.e., open language). The term coupled, as used herein, is defined as connected, although not necessarily directly, and not necessarily mechanically.

The appended claims are not to be interpreted as including means-plus-function limitations, unless such a limitation is explicitly recited in a given claim
10 using the phrase(s) "means for" and/or "step for." Subgeneric embodiments of the invention are delineated by the appended independent claims and their equivalents. Specific embodiments of the invention are differentiated by the appended dependent claims and their equivalents.